Search Notes

Application/Control No.	Applicant(s)/Patent Reexamination	under	
09/902,966	KHAN, WAHEED 1	ED N.	
Examiner	Art Unit		
Bao-Thuy L. Nguyen	1641		

SEARCHED					
Class	Subclass	Date	Examiner		
422	56, 58, 99, 104, 59, 60	10/2/2006	BTN		
435	288.1				
435	288.2				
436	970				
436	514				
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INTERFERENCE SEARCHED					
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